g		GE Industri	al Systems	Functional Testing Specification			
Renewal Services Louisville,KY				LOU-GE-3S7505PGxxx			
Test Procedure for a Card 3S7505PG520A1							
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Functional test procedure for 3S7505PG520A1

1. SCOPE

1.1 This is a functional testing procedure for a. 3S7505PG520A1

2. STANDARDS OF QUALITY

2.1 Refer to the current revision of the IPC-A-610 standard for workmanship standards.

3. APPLICABLE DOCUMENTS

3.1 The following document(s) shall form part of this specification to the extent specified herein. Unless otherwise indicated, the latest issue shall apply.
2.1.1

4. ENGINEERING REQUIREMENTS

- 4.1 Equipment Cleaning
 - **4.1.1** Equipment should be clean and free of debris prior to applying power unless performing an initial check. Refer to the local documented procedures for cleaning guidelines.
- 4.2 Equipment Inspection
 - **4.2.1** Equipment should be visually inspected for any defects prior to applying power. This inspection should include the following as a minimum:
 - 4.2.1.1 Wires broken or cracked
 - 4.2.1.2 Terminal strips / connectors broken or cracked
 - **4.2.1.3** Loose wires
 - 4.2.1.4 Components visually damaged
 - 4.2.1.5 Capacitors leaking
 - 4.2.1.6 Solder joints damaged or cold
 - 4.2.1.7 Circuit board burned or de-laminated
 - 4.2.1.8 Printed wire runs burned or damaged

5. EQUIPMENT REQUIRED

5.1 The following equipment is required to perform the process requirements. Equipment may be substituted provided that all accuracy's and test ratios are equivalent or better.

Qty	Reference #	# Description	
1		Fluke DMM or Equivalent	
1	H033962	Test Box for photo eyes	

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6. TESTING PROCESS

- 6.1 Setup
 - **6.1.1** Make the following jumper connections: Relay pickup to dark, and lamp volts to 3.5.
 - **6.1.2** On the three pin connector, short the two pins closest to the terminal strip. (Refer to document GEH-2160.)
 - **6.1.3** Install test relay into socket on card.
 - **6.1.4** Connect test box to UUT.
 - **6.1.5** Connect 115VAC across "power" on terminal strip.
- **6.2** Testing Procedure
 - **6.2.1** Apply power to UUT
 - **6.2.2** Verify with DMM that contacts on relay open or close when shutter is closed or opened on test box.
 - 6.2.3 Remove power.
- 6.3 ***TEST COMPLETE ***

7. NOTES